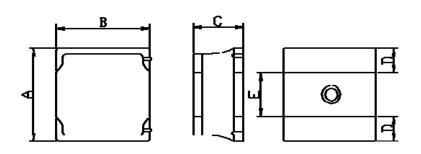


FEATRLRES

- This specification applies Low Profile Power Inductors.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

CONFIGRLRATIONS & DIMENSIONS (unit in mm)



| Туре | Α | В | С | D | E | G | н | I |
|-----------|---------|---------|---------|----------|----------|---|---|---|
| HNR3012TF | 3.0±0.2 | 3.0±0.2 | 1.2max. | 1.0 ref. | 1.0 ref. | - | - | - |

ELECTRICAL CHARACTERISTICS

| Part Number | Inductance Tolerance | | Test | DCR | I sat (A) | I sat (A) | I rms (A) | I rms (A) |
|-----------------|----------------------|------|-------------------|----------|-----------|-----------|-----------|-----------|
| Part Number | (uH) | (%) | Frequency (Hz) | (Ω) ±20% | typ. | max. | typ. | max. |
| HNR3012TF-1R0Y | 1.0 | ±30% | 0.1V/1M | 0.042 | 2.50 | 2.15 | 2.20 | 2.00 |
| HNR3012TF -1R5Y | 1.5 | ±30% | 0.1V/1M | 0.056 | 2.00 | 1.70 | 2.00 | 1.85 |
| HNR3012TF -2R2M | 2.2 | ±20% | 0.1V/1M | 0.080 | 1.80 | 1.50 | 1.90 | 1.70 |
| HNR3012TF -3R3M | 3.3 | ±20% | 0.1V/1M | 0.100 | 1.50 | 1.20 | 1.70 | 1.55 |
| HNR3012TF-4R7M | 4.7 | ±20% | 0.1V/1M | 0.130 | 1.30 | 1.05 | 1.50 | 1.30 |
| HNR3012TF-6R8M | 6.8 | ±20% | 0.1V/1M | 0.180 | 1.20 | 0.90 | 1.20 | 1.05 |
| HNR3012TF-100M | 10 | ±20% | 0.1V/1M | 0.245 | 0.90 | 0.76 | 1.00 | 0.89 |
| HNR3012TF-150M | 15 | ±20% | 0.1V/1M | 0.386 | 0.80 | 0.62 | 0.90 | 0.74 |
| HNR3012TF-220M | 22 | ±20% | 0.1V/1M | 0.580 | 0.60 | 0.49 | 0.70 | 0.61 |

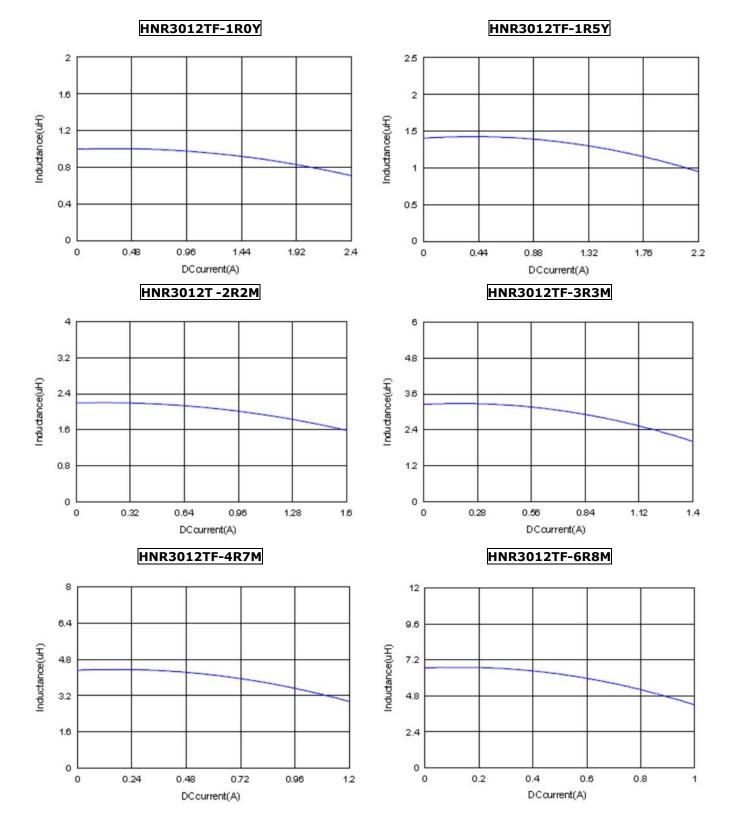
Note:

Isat : Based on inductance change $(\triangle L/L0 : \leq -30\%)$ @ ambient temp. 25° C

Irms : Based on temperature rise $(\triangle T : 40^{\circ}C \text{ typ.})$



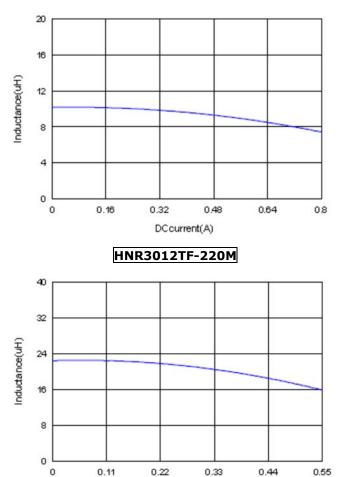
TYPICALELECTRICALCHARACTERISTICS:

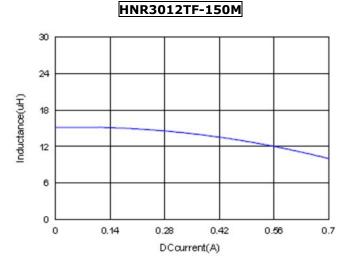




SA-SP-001

HNR3012TF-100M





Reliability and Test Condition

DCcurrent(A)

| Item | Performance | Test Condition | | | |
|-----------------------------|---|---|--|--|--|
| Operating temperature | -40~+125℃ (Including self - temperature rise) | | | | |
| Storage temperature | 110~+40℃,50~60%RH (Product with taping) 240~+125℃ (on board) | | | | |
| Electrical Performance Test | | | | | |
| Inductance | Refer to standard electrical characteristics list. | HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter. | | | |
| DCR | | CH16502, Agilent 33420A Micro-Ohm Meter. | | | |
| Saturation Current (Isat) | Approximately∆L30% | Saturation DC Current (Isat) will cause L0 to drop | | | |
| Heat Rated Current (Irms) | Approximately △T40℃ | Heat Rated Current (Irms) will cause the coil temperature rise $	riangle T(\circ)$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer | | | |
| Reliability Test | | | | | |
| | | Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) | | | |
| Life Test | | Temperature : 125±2°C (Inductor) Applied current : rated current Duration : 1000±12hrs | | | |
| | Appearance : No damage. | Measured at room temperature after placing for 24±2 hrs | | | |



| | Inductance : within±10% of initial value | Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles |
|------------------------------|---|--|
| Load Humidity | Q : Shall not exceed the specification value. | Humidity : 85±2 * R.H. |
| | RDC:within ±15% of initial value and shall not | Temperature : 85°C ±2°C |
| | exceed the specification value | Duration : 1000hrs Min. with 100% rated current |
| | | Measured at room temperature after placing for 24±2 hrs |
| Moisture Resistance | | Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs. 3. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs,keep at $25°C$ for 2 hrs then keep at $-10°C$ for 3 hrs 4. Keep at $25°C$ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for $1\sim2$ hrs. |
| Thermal shock | | Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles Condition for 1 cycle Step1: -40 ± 2 °C 30 \pm 5min Step2: 25 ± 2 °C \leq 0.5min Step3: 125 ± 2 °C 30 \pm 5min Number of cycles: 500 Measured at room temperature after placing for 24 \pm 2 hrs |
| Vibration | | Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations). |
| Bending | | Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec. |
| Shock | Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value | TypePeak value (g's)Normal duration (D)Wave formVelocity change (Vi)ft/secSMD5011Half-sine11.3Lead5011Half-sine11.3 |
| Solder ability | More than 95% of the terminal electrode should be covered with solder。 | Preheat: 150°C,60sec.₀ Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5°C ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘ Depth: completely cover the termination |
| Resistance to Soldering Heat | | Depth: completely cover the termination Temperature(°C) Time(s) Temperature ramp/immersion and emersion rate Number of heat cycles 260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1 |
| Terminal Strength | Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e | Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force(>0805:1Kg, <=0805:0.5Kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. |
| | | |

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.